

Search Notes (continued) 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/046,457	BAUER ET AL.	
	Examiner Lien T. Tran	Art Unit 1761	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
interference search as shown on printout		5/15/2006	LT